

**Search Notes****Application/Control No.**

10/663,495

**Examiner**

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**Applicant(s)/Patent under Reexamination**

KIME ET AL.

**Art Unit**

2137

**SEARCHED**

Class	Subclass	Date	Examiner
726	22-23, 29	8/9/2006	MDN
709	224-226	8/9/2006	MDN
455	404.1,410	8/9/2006	MDN
455	404.2,411	8/9/2006	MDN
455	456.1-457	8/9/2006	MDN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name search on EAST (US-PAT; US-PGPUB; DERWENT; IBM-TDB; EPO; JPO)	8/9/2006	MDN
Text and class search on EAST (US-PAT; US-PGPUB; DERWENT; IBM-TDB; EPO; JPO)	8/9/2006	MDN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner